

# 2N3091 SERIES

## 110 Amp RMS SCRs

### Major Ratings and Characteristics

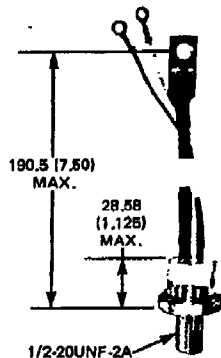
	2N3091-9B	Units
$I_T(\text{RMS})$	110	A
$I_T(\text{AV})$	70*	A
⊙ Max. $T_C$	62*	°C
$I_{TSM}$	⊙ 60 Hz	965
	⊙ 60 Hz	1000*
$I^2t$	⊙ 60 Hz	4660
	⊙ 60 Hz	4150
$I_{GT}$	110	mA
$dv/dt$	20*	V/ $\mu$ s
$dI/dt$	300	A/ $\mu$ s
$T_J$	-40 to 125	°C
$V_{RRM}, V_{DRM}$ range	600 to 1300	V

\*JEDEC registered values.

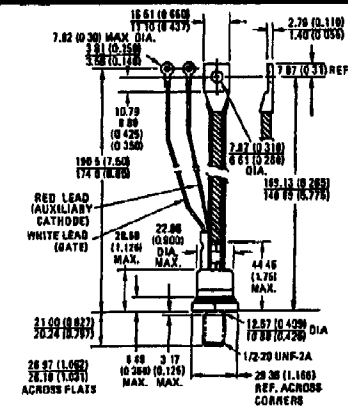
### Description/Features

- Bulk Avalanche
- Forward and reverse ratings from 600 – 1300 volts.

### CASE STYLE AND DIMENSIONS



Case style (ceramic) A-11 furnished when part is rated 1000V or higher, A-13 (glass) for parts below 1000V.



IR Case Style A-11  
 Conforms to JEDEC Outline TO-206AC (TO-64)  
 All Dimensions in Millimeters and (Inches)



NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

2N3091 Series

VOLTAGE RATINGS (Applied gate voltage zero or negative)

Part Number ①	$V_{RRM} - V_{DRM}$ Max. Repetitive Peak Reverse and Off-State Voltage (V) ②	$V_{(BR)R}$ Min. Reverse Avalanche Voltage
	$T_J = -40^\circ\text{C to } 125^\circ\text{C}$	$T_J = 25^\circ\text{C}$
2N3091	600*	700*
2N3092	700*	800*
2N3093	800*	800*
2N3094	900*	1000*
2N3096	1000*	1100*
2N3098	1100*	1200*
2N3097	1200*	1300*
2N3088	1300*	1400*

ELECTRICAL SPECIFICATIONS

	2N3091-98	Units	Conditions
<b>ON-STATE</b>			
$I_T(\text{RMS})$ Max. RMS on-state current	110	A	
$I_T(\text{AV})$ Max. average on-state current @ Max. $T_C =$	70*	A	180° half sine wave conduction
	82*	°C	
$I_{TSM}$ Max. peak one cycle, non-repetitive surge current	965	A	50 Hz half cycle sine wave or 6 ms rectangular pulse Following any rated load condition, and with rated $V_{RRM}$ applied following surge. SCR turned fully on.
	1000*		
		1150	A
	1200		
$I^2t$ Max. $I^2t$ capability, for fusing	4650	A <sup>2</sup> s	t = 10 ms Rated $V_{RRM}$ applied following surge, initial $T_J = 125^\circ\text{C}$
	4150		t = 8.3 ms
$I^2t$ Max. $I^2t$ capability, for individual device fusing	6450	A <sup>2</sup> s	t = 10 ms $V_{RRM} = 0$ following surge, initial $T_J = 125^\circ\text{C}$
	6900		t = 8.3 ms
$I^2\sqrt{t}$ Max. $I^2\sqrt{t}$ capability, for individual device fusing ③	84 500	A <sup>2</sup> $\sqrt{s}$	$V_{RRM}$ following surge = 0. Initial $T_J < 125^\circ\text{C}$ t = 0.1 to 10ms.
$V_{TM}$ Max. peak on-state voltage	1.95*	V	$T_J = 25^\circ\text{C}$ , $I_T(\text{AV}) = 70\text{A}$ (220A peak)
$I_H$ Max. holding current	500	mA	$T_C = 25^\circ\text{C}$ , anode supply = 22V, initial $I_T = 3\text{A}$ .
<b>BLOCKING</b>			
$dv/dt$ Min. critical rate of rise of off-state voltage	20*	V/ $\mu\text{s}$	$T_J = 125^\circ\text{C}$ . Exponential to 100% rated $V_{DRM}$ ; gate open circuited
$I_{RM}$ & $I_{DM}$ Max. peak reverse and off-state current 300V - 600V	5*	mA	Max. rated $T_J$ , rated $V_{RRM}$ ; gate open circuited.

① Meets MIL-S-19500/280A when ordered as JAN2N - - - -

② Units may be broken over without damage if  $dv/dt$  does not exceed 20 A/ $\mu\text{s}$ .

③  $I^2t$  for time  $t_x = I^2\sqrt{t} \sqrt{t_x}$ .

\* JEDEC registered values.

### ELECTRICAL SPECIFICATIONS (Continued)

	2N3901-98	Units	Conditions
<b>SWITCHING</b>			
$t_d$	Typical delay time	1	$T_C = 25^\circ\text{C}$ , rated $V_{DRM}$
$t_r$	Typical rise time	1	$I_{TM} = 50\text{A}$ resistive circuit, Gate pulse: 10V, 25 $\mu\text{s}$ , $t_p = 8\mu\text{s}$
$t_f$	Typical turn-off time	50	$T_C = 125^\circ\text{C}$ , $I_{TM} = 50\text{A}$ , $dv/dt = 5\text{A}/\mu\text{s}$ , $V_R = 50\text{V}$ , resupplied $dv/dt = 20\text{V}/\mu\text{s}$ linear to rated $V_{DRM}$ . Gate bias: 0V, 100 $\Omega$ .
$di/dt$	Max. non-repetitive rate of rise of turned-on current = $V_{RRM}$ = 500V to 600V = 700V to 1000V = 1100V to 1400V	300 225 160	$T_C = 125^\circ\text{C}$ , $V_{VDM} = \text{rated } V_{DRM}$ , $I_{TM} = (2 \times di/dt)$ or $(2 \times \text{rated } I_T(AV))\text{A}$ (whichever is the greater), Gate pulse: 20V, 15 $\Omega$ , $t_p = 6\text{ms}$ , $t_f = 0.1\mu\text{s}$ . Per JEDEC standard RS397, 5.2.2.6.
		A/ $\mu\text{s}$	
<b>TRIGGERING</b>			
$P_{GM}$	Max. peak gate power	5*	W $t_p < 5\text{ms max.}$
$P_{G(AV)}$	Max. average gate power	0.5*	W
$I_{GM}$	Max. peak positive gate current	2	A
$+V_{GM}$	Max. peak positive gate voltage	20*	V
$-V_{GM}$	Max. peak negative gate voltage	5*	V
$I_{GT}$	Max. required DC gate current to trigger	200*	mA $T_C = -40^\circ\text{C}$ . Max. required gate trigger voltage is the lowest value which will trigger all units with +6V anode-to-cathode.
		110	mA $T_C = 25^\circ\text{C}$
		50	mA $T_C = 125^\circ\text{C}$
		25	mA $T_C = 25^\circ\text{C}$ +6V anode-to-cathode
$V_{GT}$	Max. required DC gate voltage to trigger	3*	V $T_C = -40^\circ\text{C}$ . Max. required gate trigger voltage is the lowest value which will trigger all units with +6V anode-to-cathode.
		2.5	V $T_C = 25^\circ\text{C}$
		1	V $T_C = 25^\circ\text{C}$ +6V anode-to-cathode
$V_{GD}$	Max. DC gate voltage not to trigger	0.20*	V $T_C = 125^\circ\text{C}$ . Max. gate voltage not to trigger is the maximum value which will not trigger any unit with rated $V_{DRM}$ anode-to-cathode.

### THERMAL-MECHANICAL SPECIFICATIONS

	2N3901-98	Units	Conditions
$T_J$	Operating junction temperature range	$-40^\circ$ to $125^\circ$	$^\circ\text{C}$
$T_{stg}$	Storage temperature range	$-40^\circ$ to $125^\circ$	$^\circ\text{C}$
$R_{thJC}$	Max. internal thermal resistance, junction to case	0.4*	K/W DC operation
$R_{thCS}$	Thermal resistance, case to sink	0.1	K/W Mounting surface smooth, flat and greased.
T	Mounting torque	Min.	14.5 (125) N m (lbf-in)
		Max.	17.0 (150) N m (lbf-in)
	Max. torque on screw in flag terminal	1.4 (12)	N m (lbf-in)
wt	Approximate weight	100 (3.5)	g (oz)
	Case Style	TO-208AC (TO-94) (IR case Style A-11)	JEDEC

\*JEDEC registered values.